

Search Notes				Application/Control No.	Applicant(s)/Patent under Reexamination
				10/768,650	NAKANISHI ET AL.
				Examiner	Art Unit
				BINH Q. TRAN	3748

SEARCHED			
Class	Subclass	Date	Examiner
60	274	05/24/05	BS
	275		
	286		
	297		
	301		
✓	303	✓	✓
422	186.03	05/24/05	BS
	186.04		
	186.07		
✓	186.24	✓	✓
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Searched 10/05/05 BS to dated			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Searched	10/12/05	BS	
all of the			
above			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST TEXT SEARCHED	05/24/05	BS
INVENTOR SEARCHED	10/05/05	BS